MPXM2051G

50 kPa Temperature Compensated Pressure Sensors

Rev. 5 — 22 April 2021

Product data sheet

1 General Description

The MPXM2051G device is a silicon piezoresistive pressure sensor providing a highly accurate and linear voltage output directly proportional to the applied pressure. The sensor is a single monolithic silicon diaphragm with the strain gauge and a thin-film resistor network integrated on-chip. The chip is laser trimmed for precise span and offset calibration and temperature compensation.

2 Features and Benefits

- · Ratiometric to Supply Voltage
- Available in Easy-to-Use Tape & Reel
- Temperature Compensated over 0 °C to 85 °C
- Gauge Ported

3 Applications

- · Level Indicators
- · Medical Diagnostics
- Robotics
- · Pressure Switching
- Pump/Motor Controllers
- Non-Invasive Blood Pressure Measurement



4 Ordering Information

Table 1. Ordering options

Device name	Package options	Case number	Nur	Number of ports Pressure type		е	Device marking		
		Case Humber	None	Single	Dual	Gauge	Differential	Absolute	Device marking
MPXM2051GST1	Tape & Reel	<u>1320A</u>		•		•			MPXM2051GS

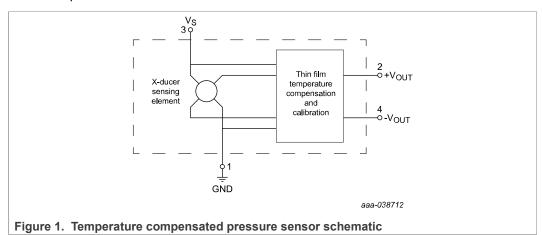
MPAK Package



MPXM2051GST1 Case 1320A

5 Block Diagram

<u>Figure 1</u> shows a block diagram of the internal circuitry on the stand-alone pressure sensor chip.



6 Pin Information

6.1 MPXM2051GST1

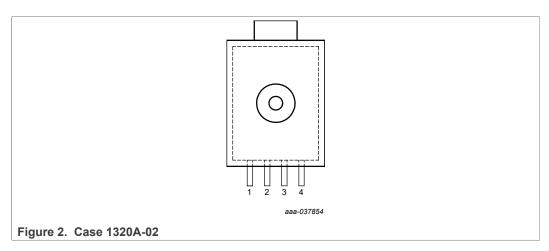


Table 2. Pin definitions - MPXM2051GST1

Symbol	Pin	Description
GND	1	Ground
+V _{OUT}	2	+ Voltage output
Vs	3	Power supply
-V _{OUT}	4	- Voltage output

7 Maximum Ratings

Table 3. Maximum ratings

Exposure beyond the specified limits may cause permanent damage or degradation to the device. In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
P _{max}	Overpressure	P1 > P2	_	_	200	kPa
T _{stg}	Storage Temperature		-40	_	+125	°C
T _A	Operating Temperature		-40	_	+125	°C

8 Operating Characteristics

Table 4. Operating Characteristics ($V_S = 10 \text{ Vdc}$, $T_A = 25 ^{\circ}\text{C}$ unless otherwise noted, P1 > P2)

Characteristic		Symbol	Min	Тур	Max	Unit
Operating Pressure Range	[1]	P _{OP}	0	_	50	kPa
Supply Voltage	[2]	V _S	_	10	16	Vdc
Supply Current		Io	_	6.0	_	mAdc
Full Scale Span	[3]	V _{FSS}	38.5	40	41.5	mV
Offset	[4]	V _{off}	-1.0	_	1.0	mV
Sensitivity		ΔV/ΔΡ	_	0.8	_	mV/kPa
Linearity	[5]	_	-0.3	_	3.0	%V _{FSS}
Pressure Hysteresis (0 kPa to 50 kPa)	[5]	_	_	±0.1	_	%V _{FSS}
Temperature Hysteresis (–40 °C to 125 °C)	[5]	_	_	±0.5	_	%V _{FSS}
Temperature Coefficient of Full Scale Span	[5]	TCV _{FSS}	-1.0	_	1.0	%V _{FSS}
Temperature Coefficient of Offset	[5]	TCV _{off}	-1.0	_	1.0	mV
Input Impedance		Z _{in}	1000	_	2500	Ω
Output Impedance		Z _{out}	1400	_	3000	Ω
Response Time (10% to 90%)	[6]	t _R	_	1.0	_	ms
Warm-Up Time	[7]	<u> </u>	_	20	_	ms
Offset Stability	[8]	_	_	±0.5	_	%V _{FSS}

- [1] 1.0 kPa equals 0.145 PSI.
- [2] Device is ratiometric within this specified excitation range. Operating the device above the specified excitation range may induce additional error due to device self-heating.
- [3] Full Scale Span (V_{FSS}) is defined as the algebraic difference between the output voltage at full rated pressure and the output voltage at the minimum rated pressure.
- [4] Offset (Voff) is defined as the output voltage at the minimum rated pressure.
- 5] Accuracy (error budget) consists of the following:
 - · Linearity: Output deviation from a straight line relationship with pressure, using end point method, over the specified pressure range.
 - Temperature Hysteresis: Output deviation at any temperature within the operating temperature range, after the temperature is cycled to and from the minimum or maximum operating temperature points, with zero differential pressure applied
 - Pressure Hysteresis: Output deviation at any pressure within the specified range, when this pressure is cycled to and from the minimum or maximum rated pressure at 25 °C.
 - TcSpan: Output deviation at full rated pressure over the temperature range of 0 °C to 85 °C, relative to 25 °C.
 - TcOffset: Output deviation with minimum rated pressure applied, over the temperature range of 0 °C to 85 °C, relative to 25°C.
- [6] Response Time is defined as the time for the incremental change in the output to go from 10% to 90% of its final value when subjected to a specified step change in pressure.
- [7] Warm-Up Time is defined as the time required for the product to meet the specified output voltage after the pressure has been stabilized.
- [8] Offset Stability is the product's output deviation when subjected to 1000 hours of Pulsed Pressure Temperature Cycling with Bias test.

9 Characteristics

9.1 Voltage output versus applied differential pressure

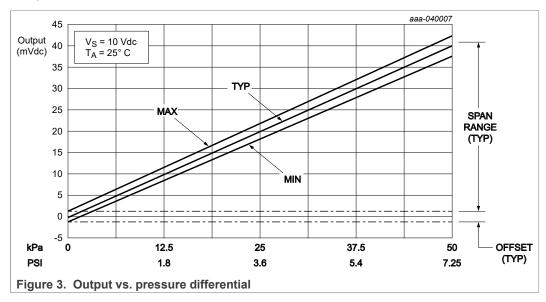
The output voltage of the differential or gauge sensor increases with increasing pressure applied to the pressure side (P1) relative to the vacuum side (P2). Similarly, output voltage increases as increasing vacuum is applied to the vacuum side (P2) relative to the pressure side (P1).

9.2 On-chip temperature compensation and calibration

Figure 3 shows the typical output characteristics of the MPXM2051G series at 25 °C.

The effects of temperature on full scale span and offset are very small and are shown under Section 8 "Operating Characteristics".

This performance over temperature is achieved by having both the shear stress strain gauge and the thin-film resistor circuitry on the same silicon diaphragm. Each chip is dynamically laser trimmed for precise span and offset calibration and temperature compensation.



9.3 Linearity

Linearity refers to how well a transducer's output follows the equation $V_{out} = V_{off} + Sensitivity \times P$ over the operating pressure range (Figure 4). There are two basic methods for calculating nonlinearity:

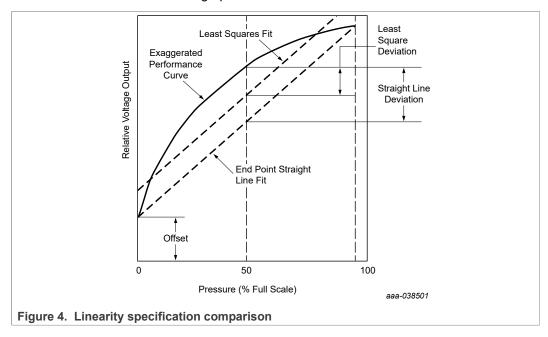
- End point straight line fit
- · Least squares best line fit

While a least squares fit gives the "best case" linearity error (lower numerical value), the calculations required are burdensome.

Conversely, an end point fit will give the "worst case" error (often more desirable in error budget calculations) and the calculations are more straightforward for the user.

MPXM2051G

NXP's specified pressure sensor linearities are based on the end point straight line method measured at the midrange pressure.



9.4 Pressure (P1) / Vacuum (P2) side identification

NXP designates the two sides of the pressure sensor as the Pressure (P1) side and the Vacuum (P2) side. The Pressure (P1) side is the side containing silicone gel that isolates the die from the environment. The NXP MPX pressure sensor is designed to operate with positive differential pressure applied, P1 > P2.

The Pressure (P1) side may be identified by using <u>Table 5</u>.

Table 5. Pressure (P1) side delineation table

Part Number	Case Type	Pressure (P1) Side Identifier
MPXM2051GST1	1320A	Side with Port Attached

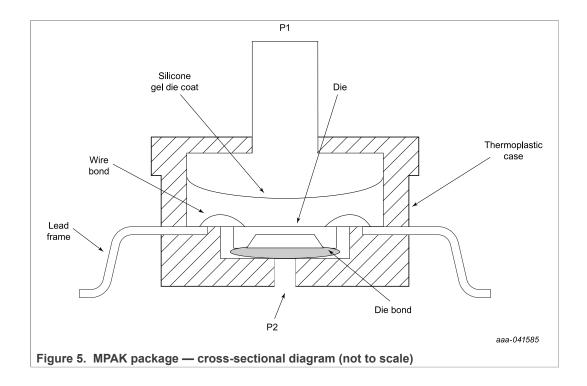
9.5 Media compatibility

<u>Figure 5</u> illustrates the gauge configuration in a typical chip carrier. A silicone gel isolates the die surface and wire bonds from the environment while allowing the pressure signal to be transmitted to the silicon diaphragm.

The MPXM2051G series pressure sensor operating characteristics, internal reliability and qualification tests are based on the use of dry clean air as the pressure medium. Media other than dry clean air may have adverse effects on sensor performance and long term reliability. Contact the factory for information regarding media compatibility in your application.

For more information, refer to application note AN3728.

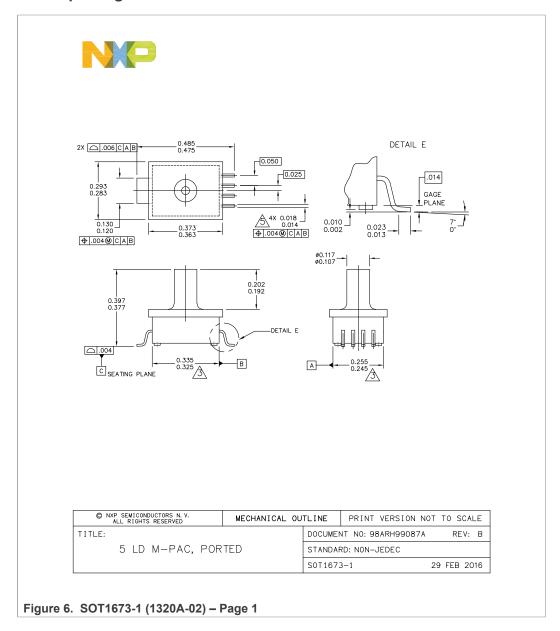
50 kPa Temperature Compensated Pressure Sensors



10 Package Outlines

Package dimensions are provided in package drawings. To find the most current package outline drawing, go to https://www.nxp.com/ and perform a keyword search for the drawing's document number.

10.1 MPAK packages



50 kPa Temperature Compensated Pressure Sensors



NOTES

- 1. DIMENSIONS ARE IN INCHES.
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

 $\underline{\mathring{\Delta}}$ DIMENSIONS DOES NOT INCLUDE MOLD FLASH OR PROTRUSION. MOLD FLASH OR PROTRUSION SHALL NOT EXCEED .006" PER SIDE.

4. ALL VERTICAL SURFACES TO BE 5" MAXIMUM.

 $\stackrel{\triangle}{\triangle}$ dimension does not include dambar protrusion. Allowable dambar protrusion shall be .008 maximum.

© NXP SEMICONDUCTORS N. V. ALL RIGHTS RESERVED	MECHANICAL OUTLIN	NE PRINT VERSION NOT TO SCALE
TITLE:	DOG	CUMENT NO: 98ARH99087A REV: B
5 LD M-PAC, PORT	TED STA	ANDARD: NON-JEDEC
	S01	T1673-1 29 FEB 2016

Figure 7. SOT1673-1 (1320A-02) - Page 2

11 References

- [1] AN840 Temperature Compensation Methods For The Motorola X-ducer Pressure Sensor Element https://www.nxp.com/docs/en/application-note/AN840.pdf
- [2] AN1984 Handling Freescale Pressure Sensors https://www.nxp.com/docs/en/application-note/AN1984.pdf
- [3] AN3150 Soldering Recommendations for Pressure Sensor Devices https://www.nxp.com/docs/en/application-note/AN3150.pdf
- [4] AN1318 Interfacing Semiconductor Pressure Sensors to Microcomputers https://www.nxp.com/docs/en/application-note/AN1318.pdf
- [5] AN3728 Media Compatibility for IPS PRT Pressure Sensors https://www.nxp.com/docs/en/application-note/AN3728.pdf

12 Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
MPXM2051G v.5	20210422	Product data sheet	_	MPXM2051G v.4				
Modifications	_	Redesigned the data sheet to comply with the new identity guidelines of NXP Semiconductors. Adapted legal texts to the new company name where appropriate.						
MPXM2051G v.4	202006	Product data sheet	_	MPXM2051G v.3				
Modifications	guidelines of N • Updated the p • Table 4, Added Temperature E	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Updated the package image on the first page. Table 4, Added new footnote after Linearity, Pressure Hysteresis, Temperature Hysteresis, Temperature Effect on Full Scale Span and Temperature Effect on Offset. Section 10 "Package Outlines", Updated the package drawing images. 						
MPXM2051G v.3	201511	Product data sheet	_	_				
Modifications	Updated format							

13 Legal information

13.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

13.2 Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

13.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors. In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory. Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXF Semiconductors

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without

notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

 $\ensuremath{\mathbf{Applications}}$ — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification. Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products. NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

MPXM2051G

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2021. All rights reserved.

50 kPa Temperature Compensated Pressure Sensors

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified or documented vulnerabilities. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's

applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer should regularly check security updates from NXP and follow up appropriately. Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP. NXP has a Product Security Incident Response Team (PSIRT) (reachable at PSIRT@nxp.com) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

13.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

NXP — wordmark and logo are trademarks of NXP B.V.

50 kPa Temperature Compensated Pressure Sensors

Tables

Tab. 1.	Ordering options2 Pin definitions – MPXM2051GST1	Tab. 4.	Operating Characteristics (VS = 10 Vdc, TA = 25 °C unless otherwise noted, P1 > P2)5
Tab. 3.	Maximum ratings4	Tab. 5.	Pressure (P1) side delineation table
145. 0.	Waxiiiaii Takiigo	Tab. 6.	Revision history11
Figur	es		
Fig. 1.	Temperature compensated pressure sensor schematic	Fig. 5.	MPAK package — cross-sectional diagram (not to scale)
Fig. 2.	Case 1320A-023	Fig. 6.	SOT1673-1 (1320A-02) – Page 19
Fig. 3.	Output vs. pressure differential6	Fig. 7.	SOT1673-1 (1320A-02) – Page 2 10
Fig. 4.	Linearity specification comparison	_	· · · · ·

Contents

1	General Description	1
2	Features and Benefits	1
3	Applications	1
4	Ordering Information	2
5	Block Diagram	3
6	Pin Information	3
6.1	MPXM2051GST1	3
7	Maximum Ratings	4
8	Operating Characteristics	5
9	Characteristics	6
9.1	Voltage output versus applied differential	
	pressure	6
9.2	On-chip temperature compensation and	
	calibration	6
9.3	Linearity	6
9.4	Pressure (P1) / Vacuum (P2) side	
	identification	7
9.5	Media compatibility	7
10	Package Outlines	
10.1	MPAK packages	9
11	References	11
12	Revision history	11
13	Legal information	

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

NXP:

MPXM2051GS MPXM2051GST1